Acta Crystallographica Section E Structure Reports Online

ISSN 1600-5368

Redetermination of 9,10-dimethylanthracene

Bernard Marciniak

Institute of Chemistry and Environment Protection, Jan Dlugosz University, al. Armii Krajowej 13/15, 42-200 Czestochowa, Poland Correspondence e-mail: crystal@cz.onet.pl

Received 1 June 2007; accepted 5 June 2007

Key indicators: single-crystal X-ray study; T = 290 K; mean σ (C–C) = 0.002 Å; disorder in main residue; R factor = 0.045; wR factor = 0.137; data-to-parameter ratio = 10.8.

The crystal structure of the title compound, $C_{16}H_{14}$, was refined by Iball & Low [*Acta Cryst.* (1974). B**30**, 2203–2205] to an *R* value of 0.080. The present redetermination confirms the previous study but with improved precision and with all H atoms located and refined. The atoms of the methyl group are disordered over two sites with occupancies 0.55 (3) and 0.45 (3). The molecular symmetry is C_i . The crystal structure is stabilized by van der Waals interactions.

Related literature

For the previous structure determination, see: Iball & Low (1974) [refcode DMANTR, Cambridge Structural Database, Version 5.28; Allen, 2002)].



Experimental

Crystal data

C₁₆H₁₄ $M_r = 206.27$ Monoclinic, $P2_1/c$ a = 7.8229 (6) Å b = 5.3093 (4) Å c = 13.4649 (10) Å $\beta = 93.861$ (7)°

Data collection

Oxford Diffraction Xcalibur3 CCD diffractometer Absorption correction: analytical (*CrysAlis RED*; Oxford Diffraction, 2007) $T_{min} = 0.947, T_{max} = 0.994$

Refinement

 $R[F^2 > 2\sigma(F^2)] = 0.046$ $wR(F^2) = 0.137$ S = 1.111003 reflections 93 parameters $V = 557.98 (7) \text{ Å}^{3}$ Z = 2Mo K\alpha radiation $\mu = 0.07 \text{ mm}^{-1}$ T = 290 (2) K $0.50 \times 0.16 \times 0.04 \text{ mm}$

3013 measured reflections 1003 independent reflections 692 reflections with $I > 2\sigma(I)$ $R_{int} = 0.020$

H atoms treated by a mixture of
independent and constrained
refinement
$\Delta \rho_{\rm max} = 0.17 \text{ e } \text{\AA}^{-3}$
$\Delta \rho_{\rm min} = -0.17 \text{ e} \text{ Å}^{-3}$

Data collection: *CrysAlis CCD* (Oxford Diffraction, 2007); cell refinement: *CrysAlis RED* (Oxford Diffraction, 2007); data reduction: *CrysAlis RED*; program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *PLATON* (Spek, 2003) and *DIAMOND* (Brandenburg, 2006); software used to prepare material for publication: *SHELXL97*.

Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: KP2114).

References

Allen, F. H. (2002). Acta Cryst. B58, 380-388.

Brandenburg, K. (2006). *DIAMOND*. Release 3.1.e. Crystal Impact GbR, Bonn, Germany.

- Iball, J. & Low, J. M. (1974). Acta Cryst. B30, 2203-2205.
- Oxford Diffraction (2007). CrysAlis CCD and CrysAlis RED. Versions 1.171.31. Oxford Diffraction Ltd, Abingdon, Oxfordshire, England.
- Sheldrick, G. M. (1997). SHELXS97 and SHELXL97. University of Göttingen, Germany.
- Spek, A. L. (2003). J. Appl. Cryst. 36, 7-13.

supplementary materials

Acta Cryst. (2007). E63, o3183 [doi:10.1107/S1600536807027511]

Redetermination of 9,10-dimethylanthracene

B. Marciniak

Comment

In the literature, there is a single paper related to the crystal structure of 9,10-dimethylanthracene (I) [Iball & Low, 1974; CSD refcode DMANTR (Cambridge Structural Database, Version 5.28; Allen, 2002)]. In that determination, a reliability factor was R=0.080 for 712 data, and hydrogen atom coordinates were included in calculated positions without any refinement. However, the redetermination of (I) from recollected intensity data is presented here. The disorder of methyl group was detected over two sites (Fig. 1) with site occupancy factors 0.55 (3) and 0.45 (3). Apart from this disorder and the higher precision of the geometric parameters [σ (C—C) = 0.002–0.003 Å in the present work, compared with 0.009–0.012 Å in the earlier work (Iball & Low, 1974)], the results obtained agree well with the already published data. In the crystal structure of (I) the asymmetric unit consists of a half-molecule whereas the other half is generated by a centre of inversion. The molecule is planar with the largest r.m.s. deviation from the best least-square plane being 0.005 (1) Å for C5. The crystal packing is stabilized by van der Waals interactions (Fig. 2).

Experimental

The crystals of (I) were obtained from the vapour in a specially constructed glass apparatus consisting of the two main parts, namely a cold copper plate used as a substrate and an electrically heated molybdenic boat, both equipped with the Fe/constant thermocouples which allowed an independent control of the T₁ and T₂ temperatures of these parts, respectively. Under a low background pressure of 10^{-3} mbar, the crystals were nucleated at 311 K/330 K (T₁/T₂) and grown at 318 K /330 K.

Refinement

All C-bound H atoms, except those on C8 atom were included in the refinement at the geometrically calculated positions and refined using a riding model with C—H distances of 0.93 Å and with $U_{iso}(H)=1.2U_{eq}(C)$. The H atoms of methyl group were located in a difference Fourier map and refined with $U_{iso}(H)=1.5U_{eq}(C)$. These atoms were found to be disordered over two sites with refined occupancies of 0.55 (3): 0.45 (3).

Figures



Fig. 1. View of molecule of (I) showing the atom-numbering scheme and disordered H atoms of methyl group. Displacement ellipsoids are drawn at the 20% probability level and H atoms are shown as small spheres of arbitrary radii. Symetry code (*a*): 1 - x, -y, 1 - z.



Fig. 2. The crystal packing, viewed along the *a* axis.

9,10-dimethylanthracene

Crystal	data

C₁₆H₁₄ $M_r = 206.27$ Monoclinic, $P2_1/c$ Hall symbol: -P 2ybc a = 7.8229 (6) Å b = 5.3093 (4) Å c = 13.4649 (10) Å

 $\beta = 93.861 (7)^{\circ}$ $V = 557.98 (7) \text{ Å}^3$ Z = 2

Data collection

Oxford Diffraction Xcalibur3 CCD diffractometer	1003 independent reflections
Radiation source: fine-focus sealed tube	692 reflections with $I > 2\sigma(I)$
Monochromator: graphite	$R_{\rm int} = 0.020$
T = 290(2) K	$\theta_{\rm max} = 25.4^{\circ}$
ω scans	$\theta_{\min} = 2.6^{\circ}$
Absorption correction: analytical (CrysAlis RED; Oxford Diffraction, 2007)	$h = -9 \rightarrow 9$
$T_{\min} = 0.947, \ T_{\max} = 0.994$	$k = -3 \rightarrow 6$
3013 measured reflections	$l = -16 \rightarrow 16$

Refinement

Refinement on F^2	Hydrogen site location: inferred from neighbouring sites
Least-squares matrix: full	H atoms treated by a mixture of independent and constrained refinement
$R[F^2 > 2\sigma(F^2)] = 0.046$	$w = 1/[\sigma^2(F_o^2) + (0.0784P)^2 + 0.0148P]$ where $P = (F_o^2 + 2F_c^2)/3$
$wR(F^2) = 0.137$	$(\Delta/\sigma)_{max} < 0.001$
<i>S</i> = 1.11	$\Delta \rho_{max} = 0.17 \text{ e } \text{\AA}^{-3}$
1003 reflections	$\Delta \rho_{\rm min} = -0.17 \ {\rm e} \ {\rm \AA}^{-3}$

 $F_{000} = 220$ $D_x = 1.228 \text{ Mg m}^{-3}$ Mo K α radiation $\lambda = 0.71073 \text{ Å}$ Cell parameters from 3013 reflections $\theta = 2.6-25.4^{\circ}$ $\mu = 0.07 \text{ mm}^{-1}$ T = 290 (2) K Columnar, yellow $0.50 \times 0.16 \times 0.04 \text{ mm}$

parameters	Extinction correction: SHELXL97, $Fc^*=kFc[1+0.001xFc^2\lambda^3/sin(2\theta)]^{-1/4}$		
Primary atom site location: structure-invariant direct methods	Extinction coefficient: 0.13 (2)		

Secondary atom site location: difference Fourier map

Special details

Geometry. All e.s.d.'s (except the e.s.d. in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell e.s.d.'s are taken into account individually in the estimation of e.s.d.'s in distances, angles and torsion angles; correlations between e.s.d.'s in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell e.s.d.'s is used for estimating e.s.d.'s involving l.s. planes.

Refinement. Refinement of F^2 against ALL reflections. The weighted *R*-factor *wR* and goodness of fit S are based on F^2 , conventional *R*-factors *R* are based on F, with F set to zero for negative F^2 . The threshold expression of $F^2 > 2 \operatorname{sigma}(F^2)$ is used only for calculating *R*-factors(gt) *etc.* and is not relevant to the choice of reflections for refinement. *R*-factors based on F^2 are statistically about twice as large as those based on F, and R– factors based on ALL data will be even larger.

	x	у	Ζ		$U_{\rm iso}$ */ $U_{\rm eq}$	Occ. (<1)
C1	0.1584 (2)	0.1546 (3)	0.304	410 (13)	0.0641 (5)	
H1	0.0550	0.1503	0.265	57	0.077*	
C2	0.1862 (2)	-0.0076 (3) 0.38	108 (13)	0.0571 (5)	
H2	0.1008	-0.1222	0.394	44	0.069*	
C3	0.34228 (18)	-0.0089 (2) 0.442	254 (10)	0.0464 (5)	
C4	0.62951 (19)	0.1785 (2)	0.47	711 (11)	0.0468 (5)	
C5	0.47336 (19)	0.1693 (2)	0.419	972 (10)	0.0464 (5)	
C6	0.4366 (2)	0.3365 (3)	0.33	742 (12)	0.0580 (5)	
H6	0.5191	0.4533	0.32	16	0.070*	
C7	0.2856 (2)	0.3297 (3)	0.282	208 (13)	0.0649 (6)	
H7	0.2658	0.4412	0.229	93	0.078*	
C8	0.7676 (3)	0.3651 (4)	0.454	414 (18)	0.0626 (6)	
H8A	0.798 (6)	0.474 (9)	0.514	4 (4)	0.094*	0.55 (3)
H8B	0.732 (7)	0.460 (10)	0.402	2 (4)	0.094*	0.55 (3)
H8C	0.871 (7)	0.268 (9)	0.440	0 (4)	0.094*	0.55 (3)
H8D	0.801 (8)	0.352 (10)	0.379	9 (5)	0.094*	0.45 (3)
H8E	0.876 (9)	0.355 (11)	0.49	5 (4)	0.094*	0.45 (3)
H8F	0.732 (8)	0.540 (11)	0.449	9 (5)	0.094*	0.45 (3)
Atomic displa	acement parameters	$(Å^2)$				
	U^{11}	U^{22}	U^{33}	U^{12}	U^{13}	U^{23}
C1	0.0578 (11)	0.0703 (11)	0.0630(11)	0.0084 (9)	-0.0039 (9)	-0.0041 (9)
C2	0.0506 (9)	0.0576 (10)	0.0629 (10)	-0.0015 (7)	0.0020 (8)	-0.0076 (8)
C3	0.0471 (9)	0.0439 (8)	0.0487 (9)	0.0016 (6)	0.0077 (7)	-0.0091 (6)
C4	0.0459 (9)	0.0446 (8)	0.0511 (9)	-0.0023 (6)	0.0116 (7)	-0.0077 (6)
C5	0.0507 (9)	0.0422 (8)	0.0476 (8)	0.0021 (6)	0.0126 (7)	-0.0057 (6)
C6	0.0615 (11)	0.0539 (10)	0.0596 (10)	0.0013 (7)	0.0109 (8)	0.0031 (7)

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters (A^2)

supplementary materials

C7	0.0689 (12)	0.0666 (11)	0.0592 (10)	0.0119 (9)	0.0048 (9)	0.0048 (8)
C8	0.0575 (11)	0.0609 (11)	0.0699 (13)	-0.0118 (9)	0.0093 (10)	0.0028 (10)
Geometric param	neters (Å, °)					
C1—C2		1.354 (2)	C6—C	27	1.35	55 (2)
C1—C7		1.408 (3)	C6—H	16	0.9300	
C1—H1		0.9300	С7—Н	17	0.9300	
C2—C3		1.428 (2)	C8—H	I8A	1.00	0(5)
С2—Н2		0.9300	C8—H	I8B	0.90) (5)
C3—C4 ⁱ		1.414 (2)	C8—H	18C	0.99	9(5)
C3—C5		1.443 (2)	C8—H	I8D	1.07	7 (6)
C4—C5		1.402 (2)	C8—H	I8E	0.98	8 (6)
C4—C8		1.513 (2)	C8—H	I8F	0.97	7 (6)
С5—С6		1.434 (2)				
C2—C1—C7		120.1 (2)	C4—C	С8—Н8А	110	(2)
C2-C1-H1		119.9	C4—C	С8—Н8В	110	(3)
C7—C1—H1		119.9	H8A—	-C8—H8B	110	(4)
C1—C2—C3		122.3 (2)	C4—C	С8—Н8С	108	(3)
С1—С2—Н2		118.9	H8A—	-C8—H8C	108	(4)
С3—С2—Н2		118.9	H8B—	-C8—H8C	111	(4)
C4 ⁱ —C3—C2		122.0 (1)	C4—C	C8—H8D	112	(3)
C4 ⁱ —C3—C5		120.3 (1)	H8A—	-C8—H8D	137	(4)
C2—C3—C5		117.7 (1)	H8B—	-C8—H8D	51 (3)
C5—C4—C3 ⁱ		119.0 (1)	H8C—	-C8—H8D	62 (3)
C5—C4—C8		121.2 (2)	C4—C	С8—Н8Е	117	(3)
C3 ⁱ —C4—C8		119.8 (2)	H8A—	-C8—H8E	55 (3)
C4—C5—C6		121.7 (1)	H8B—	-C8—H8E	133	(4)
C4—C5—C3		120.7 (1)	H8C—C8—H8E		53 (3)	
C6—C5—C3		117.5 (2)	H8D—	H8D—C8—H8E		(4)
C7—C6—C5		122.0 (2)	C4—C8—H8F		116 (3)	
С7—С6—Н6		119.0	H8A—	-C8—H8F	63 (3)
С5—С6—Н6		119.0	H8B—C8—H8F		48 (4)	
C6—C7—C1		120.3 (2)	H8C—	-C8—H8F	136	(4)
С6—С7—Н7		119.8	H8D—	-C8—H8F	95 (4)
C1—C7—H7		119.8	H8E—	-C8—H8F	109	(4)
C7—C1—C2—C	3	0.1 (2)	C2—C	C3—C5—C4	179	.9 (1)
C1—C2—C3—C	4 ⁱ	179.9 (1)	C4 ⁱ —e	C3—C5—C6	-17	9.9 (1)
C1—C2—C3—C	5	-0.5 (2)	C2—C	C3—C5—C6	0.6	(2)
C3 ⁱ —C4—C5—C	26	179.8 (1)	C4—C	C5—C6—C7	-17	9.6 (1)
C8—C4—C5—C	6	-0.5 (2)	C3—C	C5—C6—C7	-0.2	2 (2)
C3 ⁱ —C4—C5—C	23	0.5 (2)	C5—C	C6—C7—C1	-0.2	2 (3)
C8—C4—C5—C	3	-179.8 (2)	C2—C	С1—С7—С6	0.2	(3)
C4 ⁱ —C3—C5—C	24	-0.5 (2)				

Symmetry codes: (i) -x+1, -y, -z+1.





